Notice of References Cited	Application/Control No. 10/710,600	Applicant(s)/Patent Under Reexamination FUJISAKI, IWAO		
	Examiner	Art Unit	Page 1 of 1	
	DAVID Q. NGUYEN	2617		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0153364	08-2003	Osann, Robert JR.	455/567
*	В	US-2003/0157929	08-2003	Janssen et al.	455/416
	U	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	J	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	C			
	>			
	w			
	х			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.